

Notice of References Cited	Application/Control No. 10/566,655		Applicant(s)/Patent Under Reexamination TODE ET AL.	
	Examiner Karie O'Neill		Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0018149	08-2001	Yageta et al.	429/224
*	B	US-2002/0012830	01-2002	Uemura et al.	429/60
*	C	US-2003/0180620	09-2003	Nakane et al.	429/231.95
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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